# 100352

100352 Low Power 8-Bit Buffer with Cut-Off Drivers



Literature Number: SNOS112



August 1998

### 100352

## Low Power 8-Bit Buffer with Cut-Off Drivers

### **General Description**

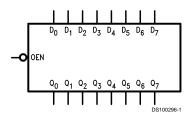
The 100352 contains an 8-bit buffer, individual inputs (Dn), outputs (Qn), and a data output enable pin  $(\overline{\text{OEN}})$ . A Q output follows its D input when the  $\overline{\text{OEN}}$  pin is LOW. A HIGH on  $\overline{\text{OEN}}$  holds the outputs in a cut-off state. The cut-off state is designed to be more negative than a normal ECL LOW level. This allows the output emitter-followers to turn off when the termination supply is -2.0V, presenting a high impedance to the data bus. This high impedance reduces termination power and prevents loss of low state noise margin when several loads share the bus.

The 100352 outputs are designed to drive a doubly terminated  $50\Omega$  transmission line (25 $\Omega$  load impedance). All inputs have 50 k $\Omega$  pull-down resistors.

### **Features**

- Cut-off drivers
- Drives 25Ω load
- Low power operation
- 2000V ESD protection
- Voltage compensated operating range = -4.2V to -5.7V
- Available to industrial grade temperature range
- Available to MIL-STD-883

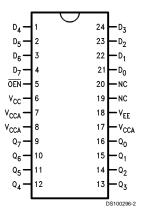
### **Logic Symbol**



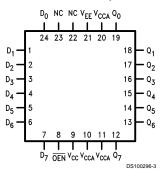
Pin Names	Description
D <sub>0</sub> -D <sub>7</sub>	Data Inputs
OEN	Output Enable Input
Q <sub>0</sub> -Q <sub>7</sub>	Data Outputs
NC	No Connect

## **Connection Diagrams**

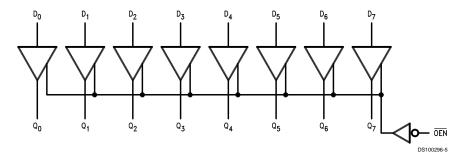
24-Pin DIP



### 24-Pin Quad Cerpak



# Logic Diagram



## **Truth Table**

Inp	Outputs	
Dn	OEN	Qn
L	L	L
Н	L	Н
Х	Н	Cutoff

H = HIGH Voltage Level
L = LOW Voltage Level
Cutoff = Lower-than-LOW State
X = Don't Care

### **Absolute Maximum Ratings** (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Above which the useful life may be impaired

Storage Temperature ( $T_{STG}$ )  $-65^{\circ}C$  to +150 $^{\circ}C$ 

Maximum Junction Temperature  $(T_J)$ 

Ceramic +175°C

 ${\rm V}_{\rm EE}$  Pin Potential to

Ground Pin -7.0V to +0.5V

Input Voltage (DC)  $V_{\rm EE}$  to +0.5V

Output Current (DC Output HIGH) -100 mA

ESD (Note 2)

≥2000V

# Recommended Operating Conditions

Case Temperature (T<sub>C</sub>)

Military -55°C to +125°C

Supply Voltage (V<sub>EE</sub>) –5.7V to –4.2V

**Note 1:** Absolute maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

# Military Version DC Electrical Characteristics

 $V_{EE}$  = -4.2V to -5.7V,  $V_{CC}$  =  $V_{CCA}$  = GND,  $T_{C}$  = -55°C to +125°C

* EE	1.2 0 0.7 0, 000 0	CCA C	<b>1</b> D, 10	00 0	0 1120 0			
Symbol	Parameter	Min	Max	Units	T <sub>C</sub>	Conditions		Notes
V <sub>OH</sub>	Output HIGH Voltage	-1025	-870	mV	0°C to +125°C	$V_{IN} = V_{IH(Max)}$	Loading	(Notes 3,
		-1085	-870	mV	−55°C	or V <sub>IL(Min)</sub>	with	4, 5)
V <sub>OL</sub>	Output LOW Voltage	-1830	-1620	mV	0°C to +125°C		25Ω to -2.0V	
		-1830	-1555	mV	−55°C		-2.0V	
V <sub>OHC</sub>	Output HIGH Voltage	-1035		mV	0°C to +125°C	$V_{IN} = V_{IH(Min)}$	Loading	(Notes 3,
		-1085		mV	−55°C	or V <sub>IL(Max)</sub>	with	4, 5)
V <sub>OLC</sub>	Output LOW Voltage		-1610	mV	0°C to +125°C		25Ω to -2.0V	
			-1555	mV	−55°C		-2.0V	
V <sub>OLZ</sub>	Cut-Off LOW Voltage		-1950	mV	0°C to +125°C	$V_{IN} = V_{IH(Min),}$ or	ŌĒN	(Notes 3,
			-1850		−55°C	V <sub>IL(Max)</sub>	=HIGH	4, 5)
V <sub>IH</sub>	Input HIGH Voltage	-1165	-870	mV	-55°C to +125°C	Guaranteed HIGH signal		1 0 0 1
						for All inputs		1, 2, 3, 4
V <sub>IL</sub>	Input LOW Voltage	-1830	-1475	mV	-55°C to +125°C	Guaranteed LOW signal		(Notes 3,
		-1030	-1473	1117		for All inputs		4, 5, 6)
I <sub>IL</sub>	Input LOW Current	0.50		μA	-55°C to +125°C	V <sub>EE</sub> = 4.2V		(Notes 3,
						$V_{IN} = V_{IL(Min)}$		4, 5)
I <sub>IH</sub>	Input HIGH Current		240	μA	0°C to + 125°C	V <sub>EE</sub> = -5.7V		(Notes 3,
			340	μA	−55°C	$V_{IN} = V_{IH(Max)}$		4, 5)
I <sub>EE</sub>	Power Supply Current				-55°C to +125°C	Inputs Open		(Notes 3,
		-145	-55	mA		$V_{EE} = -4.2V \text{ to } -4.8V$		4, 5)
		-150				$V_{EE} = -4.2V \text{ to } -5.7V$		

Note 3: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 4: Screen tested 100% on each device at -55°C, +25°C, and +125°C, Subgroups 1, 2, 3, 7, and 8.

Note 5: Sample tested (Method 5005, Table I) on each manufactured lot at -55°C, +25°C, and +125°C, Subgroups A1, 2, 3, 7, and 8.

Note 6: Guaranteed by applying specified input condition and testing  $V_{OH}/V_{OL}$ .

## **AC Electrical Characteristics**

 $V_{\rm EE}$  = -4.2V to -5.7V,  $V_{\rm CC}$  =  $V_{\rm CCA}$  = GND

Symbol	Parameter	T <sub>C</sub> = -55°C		T <sub>C</sub> = +25°C		T <sub>C</sub> +125°C		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max			
t <sub>PLH</sub>	Propagation Delay	0.30	2.60	0.50	2.40	0.50	2.70	ns	Figures 1, 2	(Notes 7,
t <sub>PHL</sub>	Dn to Output									8, 10, 11)
t <sub>PZH</sub>	Propagation Delay	1.20	4.40	1.40	4.20	1.20	4.40	ns	Figures 1, 2	(Notes 7,
t <sub>PHZ</sub>	OEN to Output	0.70	3.00	0.70	2.80	0.70	3.20			8, 9, 11)
				•		•		•	•	

### **AC Electrical Characteristics** (Continued)

 $V_{\rm EE}$  = -4.2V to -5.7V,  $V_{\rm CC}$  =  $V_{\rm CCA}$  = GND

Symbol	Parameter	T <sub>C</sub> = -55°C		T <sub>C</sub> = +25°C		T <sub>C</sub> +125°C		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max			
t <sub>TLH</sub>	Transition Time	0.40	2.50	0.40	2.40	0.40	2.70	ns	Figures 1, 2	(Note 10)
t <sub>THL</sub>	20% to 80%, 80% to 20%									

Note 7: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals –55°C), then testing immediately after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

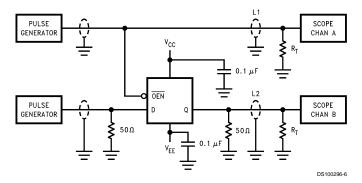
Note 8: Screen tested 100% on each device at +25°C temperature only, Subgroup A9.

Note 9: Sample tested (Method 5005, Table I) on each manufactured lot at +25°C, Subgroup A9, and at +125°C and -55°C temperatures, Subgroups A10 and A11.

Note 10: Not tested at +25°C, +125°C, and -55°C temperature (design characterization data).

Note 11: The propagation delay specified is for single output switching. Delays may vary up to 300 ps with multiple outputs switching.

### **Test Circuitry**

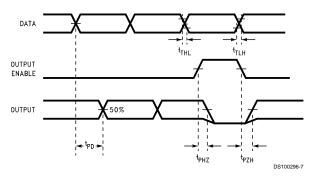


#### Notes:

V<sub>CC</sub>, V<sub>CCA</sub> = +2V, V<sub>EE</sub> = -2.5V L1 and L2 = equal length  $50\Omega$  impedance lines R<sub>T</sub> =  $50\Omega$  terminator internal to scope Decoupling 0.1 μF from GND to V<sub>CC</sub> and V<sub>EE</sub> All unused outputs are loaded with  $25\Omega$  to GND C<sub>L</sub> = Fixture and stray capacitance  $\leq$  3 pF

FIGURE 1. AC Test Circuit

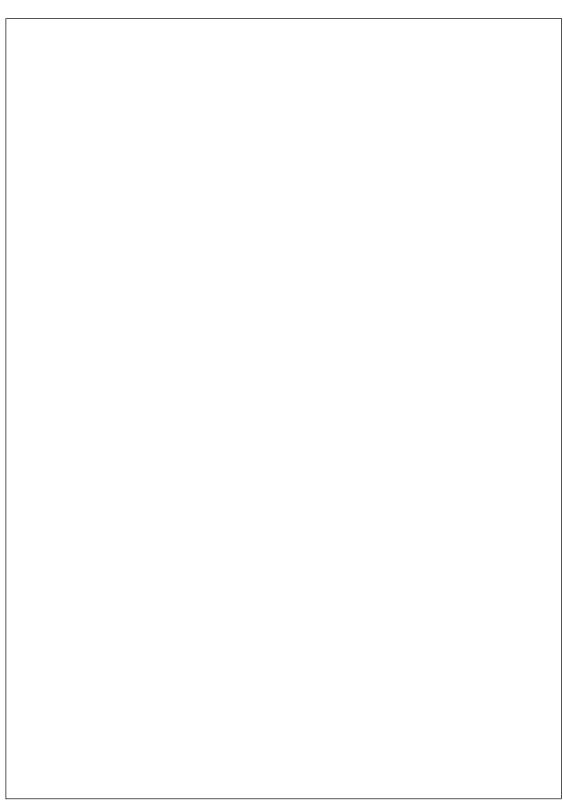
### **Switching Waveforms**

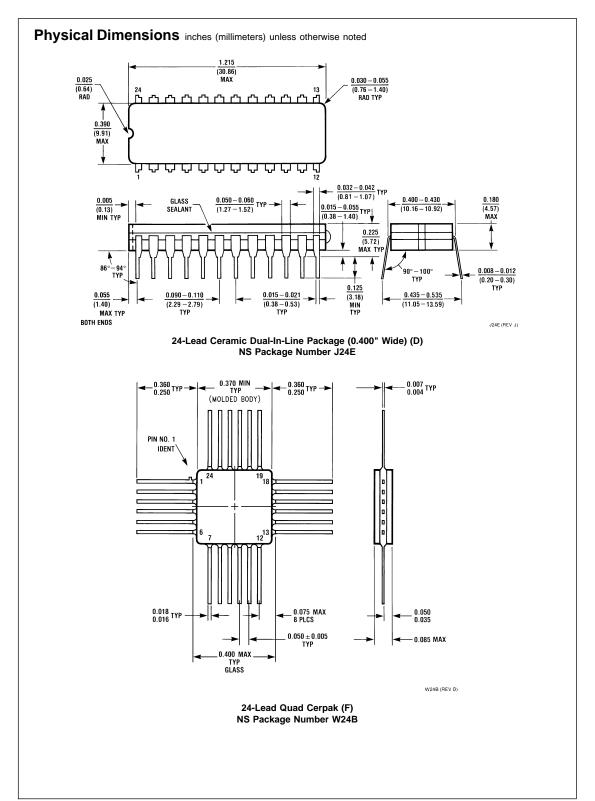


### Note:

The output AC measurement point for cut-off propagation delay testing = the 50% voltage point between active  $\rm V_{OL}$  and  $\rm V_{OH}$ .

FIGURE 2. Propagation Delay, Cut-Off and Transition Times





### LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF NATIONAL SEMI-CONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.



National Semiconductor Corporation Americas Tel: 1-800-272-9959

Americas
Tel: 1-800-272-9959
Fax: 1-800-737-7018
Email: support@nsc.com

www.national.com

National Semiconductor Europe

Fax: +49 (0) 1 80-530 85 86
Email: europe.support@nsc.com
Deutsch Tei: +49 (0) 1 80-530 85 85
English Tei: +49 (0) 1 80-532 78 32
Français Tei: +49 (0) 1 80-532 35
Italiano Tei: +49 (0) 1 80-534 16 80

National Semiconductor Asia Pacific Customer Response Group Tel: 65-2544466 Fax: 65-2504466 Email: sea.support@nsc.com

**Japan Ltd.** Tel: 81-3-5620-6175 Fax: 81-3-5620-6179

National Semiconductor

### IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products	Applications
----------	--------------

Audio www.ti.com/audio Communications and Telecom www.ti.com/communications **Amplifiers** amplifier.ti.com Computers and Peripherals www.ti.com/computers dataconverter.ti.com Consumer Electronics www.ti.com/consumer-apps **Data Converters DLP® Products** www.dlp.com **Energy and Lighting** www.ti.com/energy DSP dsp.ti.com Industrial www.ti.com/industrial Clocks and Timers www.ti.com/clocks Medical www.ti.com/medical Interface interface.ti.com Security www.ti.com/security

Logic logic.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Power Mgmt power.ti.com Transportation and Automotive www.ti.com/automotive
Microcontrollers microcontroller.ti.com Video and Imaging www.ti.com/video

RFID <u>www.ti-rfid.com</u>

OMAP Mobile Processors <u>www.ti.com/omap</u>

Wireless Connectivity www.ti.com/wirelessconnectivity

TI E2E Community Home Page e2e.ti.com

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2011, Texas Instruments Incorporated